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# Technical Compliance

Report No. ACS-E22190

**Applicant** : TPV Electronics (FuJian) Co., Ltd.  
 Rongqiao Economic and Technological Development Zone, Fuqing  
 City, Fujian Province, P.R. China

**Product** : OLED Monitor

**Model No.** : 42M2N8900; 42M2N\*\*\*\*\*; 42M\*\*\*\*\*  
 (\*=0-9,A-Z,a-z,+,-,/,\ or blank)

**Brand** : PHILIPS

## Test Standards :

BS EN 55032: 2015 (Class B) BS EN 55032: 2015+A11: 2020 BS EN 55032:2015+A1:2020	Electromagnetic compatibility of multimedia equipment - Emission requirements	
BS EN 61000-3-2: 2014, Class D BS EN IEC 61000-3-2:2019+A1: 2021	Electromagnetic compatibility(EMC) Part 3-2:Limits-Limits for harmonic current emissions(equipment input current ≤16A per phase)	
BS EN 61000-3-3: 2013 BS EN 61000-3-3: 2013+A1: 2019 BS EN 61000-3-3: 2013+A2: 2021	Electromagnetic compatibility(EMC) Part 3-3:Limits-Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current ≤16A per phase and not subject to conditional connection	
BS EN 55035: 2017 BS EN 55035: 2017+A11: 2020	Electromagnetic compatibility of multimedia equipment — Immunity requirements	
	IEC 61000-4-2: 2008	Electrostatic Discharge
	IEC 61000-4-3: 2020	RF Field Strength Susceptibility
	IEC 61000-4-4: 2012	Electrical Fast Transients
	IEC 61000-4-5: 2014+A1:2017	Surge
	IEC 61000-4-6: 2013	Continuous Conducted Disturbance
	IEC 61000-4-8: 2009	Magnetic Field Immunity
	IEC 61000-4-11: 2020	Dips / Voltage Interruption Variation

信華科技(深圳)有限公司  
 Audix Technology (Shenzhen) Co., Ltd.  
 EMC 部門報告專用章

Stamp only for EMC Dept. Report

Signature: Bensun Chen

**Bensun Chen**  
**Manager**

**Date: Nov.04, 2022**

The technical compliance is based on a single evaluation of one sample of above mentioned product. It does not imply an assessment of the whole production and does not permit the use of the test lab. logo.